

Statistical properties of serendipitous sources discovered in XRT Swift deep X-ray Images

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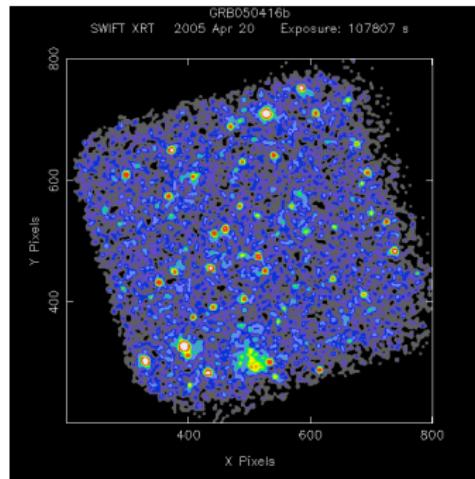
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Data

5 XRT composed images. Each one obtained by adding multiple observations of the targeted GRB afterglow

- ▶ GRB050416A
- ▶ GRB050416B
- ▶ GRB050802
- ▶ GRB060904A
- ▶ GRB060908



Each composite image obtained with a total exposure time of the order of 10^5 s

Sampling

Analysis using ximage DETECT tool

- ▶ Sliding cell method to find the sources
- ▶ Photometry with corrections to account for vignetting and PSF
- ▶ Probability threshold $2 \cdot 10^{-5}$

We obtained a catalogue composed by almost 240 sources in two energy ranges (0.3 – 3 KeV and 2 – 10 KeV). We choose two samples: one composed by the softest sources and the other by the hardest ones.

Statistical analysis

For each X band detected source we:

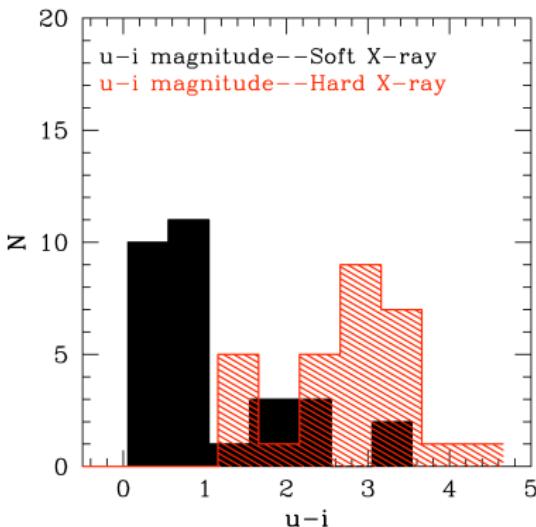
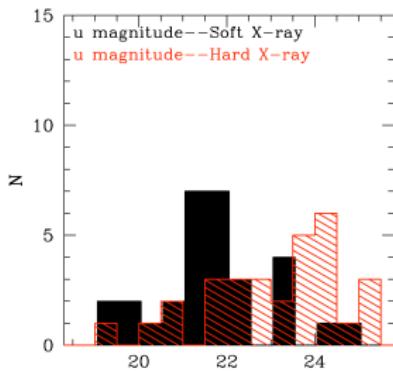
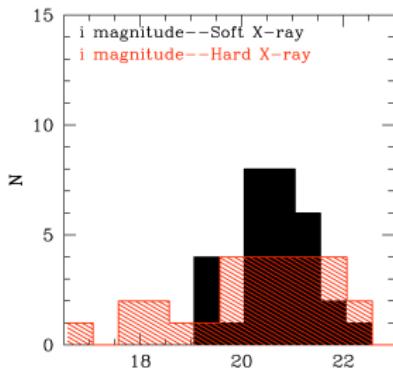
- ▶ Searched the optical catalogues and the SDSS to find counterparts
- ▶ Got the U and I magnitudes and computed the color ($U - I$)

For each sample we:

- ▶ Computed the mean value and the standard deviation for the magnitudes and the colors of the sampled sources
- ▶ Computed the $\log N - \log S$ distribution

We computed the $\log N - \log S$ distribution for the whole catalogue in order to make comparisons

Results 1



I band Soft: $M = 20.55 \sigma = 0.94$ Hard: $M = 20.49 \sigma = 1.82$

U band Soft: $M = 21.63 \sigma = 1.38$ Hard: $M = 23.06 \sigma = 1.53$

Results 2

